



P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω) (Max.)	I _D (A)	Q _g (Typ.)		
- 30	$0.018 \text{ at V}_{GS} = -4.5 \text{ V}$	- 36 ^a	33 nC		
	0.030 at V _{GS} = - 2.5 V	- 25 ^a	33110		

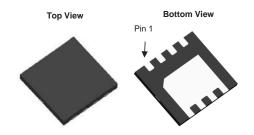
FEATURES

- DT-Trench Power MOSFET
- Thermally Enhanced DFN3X3 Package
 - Small Footprint Area
 - Low On-Resistance



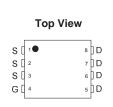
ROHS

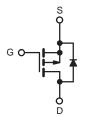
DFN 3x3 EP



APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	- 30	V	
Gate-Source Voltage		V _{GS} ± 25		7 v	
	T _C = 25 °C		- 36 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	- 26 ^a		
Continuous Diain Gunerit (1) = 130 °C)	T _A = 25 °C		- 16 ^{b, c}		
	T _A = 70 °C		- 9 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 145		
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}C$	I _S	- 36 ^a		
Continuous Gource Brain Blode Guirent	T _A = 25 °C	.0	- 12 ^{b, c}	<u> </u>	
	$T_C = 25 ^{\circ}C$		38	W	
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	20		
Maximum Fower Dissipation	$T_A = 25 ^{\circ}C$	٠ ٠	3.5 ^{b, c}		
	T _A = 70 °C		2.1 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	27	35	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3.3	4.5]	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 2 s.
- d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	In = - 250 µA		- 11		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 230 μΑ		2.7			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zana Cata Valtana Busin Osmani	I _{DSS}	V _{DS} = - 24 V, V _{GS} = 0 V			- 1	-1 -10 μΑ	
Zero Gate Voltage Drain Current		V _{DS} = - 24 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 145			Α	
	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 10 A		0.018	0.024		
Drain-Source On-State Resistance ^a	D3(011)	V _{GS} = - 4.5 V, I _D = - 8 A		0.030	0.034	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		40		S	
Dynamic ^b							
Input Capacitance	C _{iss}			2100		pF	
Output Capacitance	C _{oss}	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		980			
Reverse Transfer Capacitance	C _{rss}			490			
Total Gate Charge	Q _q	V _{DS} = - 24 V, V _{GS} = - 8 V, I _D = - 10 A		33	52		
Total Gate Charge	αg			20	31	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -24 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$		4			
Gate-Drain Charge	Q_{gd}			6			
Gate Resistance	R_g	f = 1 MHz		6		Ω	
Turn-On Delay Time	t _{d(on)}			16	27	-	
Rise Time	t _r	V_{DD} = - 24 V, R_L = 0.75 Ω		17	24		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -8 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		21	30		
Fall Time	t _f			44	65	ns	
Turn-On Delay Time	t _{d(on)}			11	17	113	
Rise Time	t _r	V_{DD} = - 24 V, R_L = 0.75 Ω		15	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 A, V_{GEN} = - 8 V, R_g = 1 Ω		30	50		
Fall Time	t _f			43	66		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 36	А	
Pulse Diode Forward Current	I _{SM}				145		
Body Diode Voltage	V _{SD}	I _S = -8 A, V _{GS} = 0 V		- 0.7	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			40	65	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 8 A, dl/dt = 100 A/µs, I ₁ = 25 °C F		20	35	nC	
Reverse Recovery Fall Time	ta			15			
Reverse Recovery Rise Time	t _b			26		ns	

Notes:

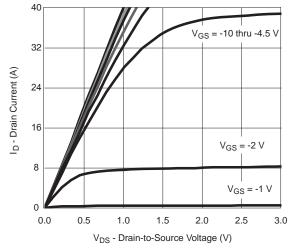
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

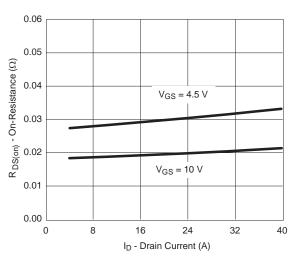
b. Guaranteed by design, not subject to production testing.



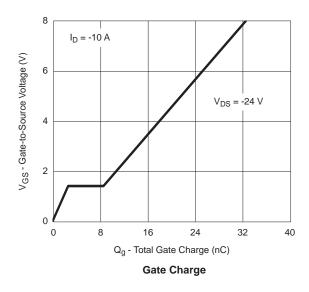
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

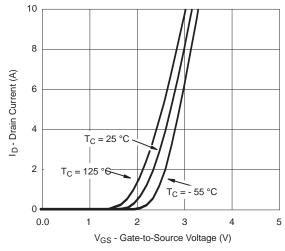


Output Characteristics

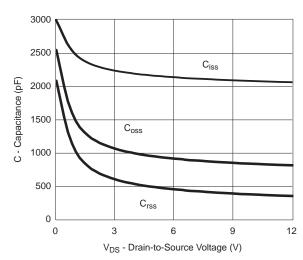


On-Resistance vs. Drain Current and Gate Voltage

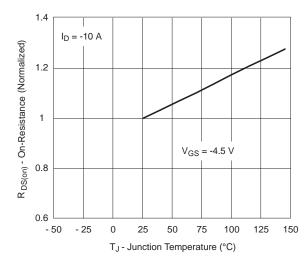




Transfer Characteristics



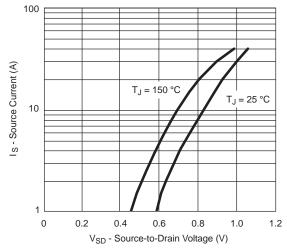
Capacitance



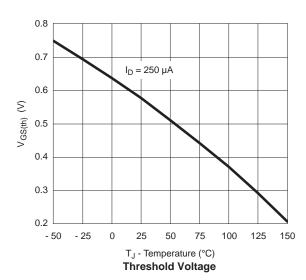
On-Resistance vs. Junction Temperature

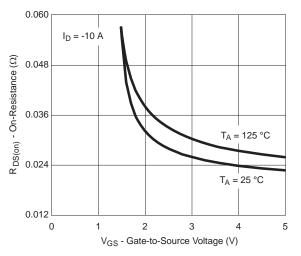


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

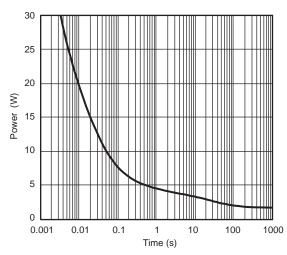


Soure-Drain Diode Forward Voltage

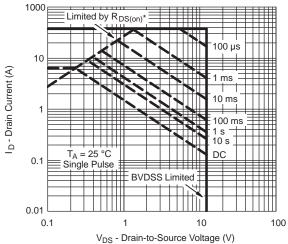




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

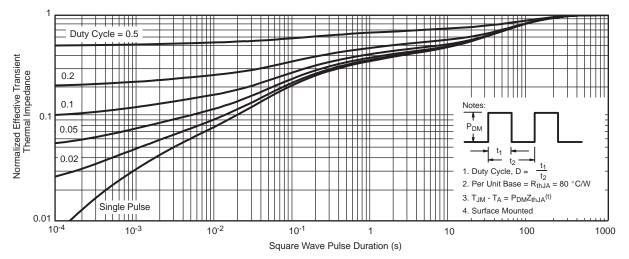


 V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

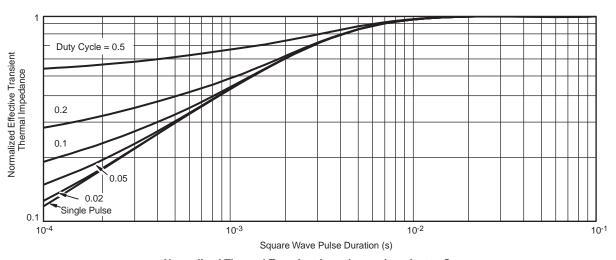
Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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